

# AOT2140L/AOB2140L

40V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT $^{\text{TM}}$  technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized Ruggedness
- RoHS and Halogen-Free Compliant

# Applications

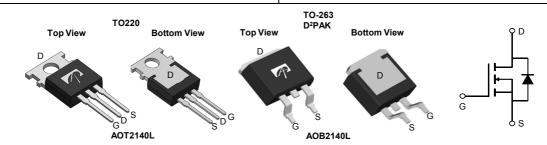
- DC Motor Driver
- Synchronous Rectification in DC/DC and AC/DC Converters

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 195A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 1.5 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 2 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT2140L	TO-220	Tube	1000
AOB2140L	TO-263	Tape & Reel	800

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	40	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain	T <sub>C</sub> =25°C		195		
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	195	A	
Pulsed Drain Current C		I <sub>DM</sub>	1000		
Continuous Drain	T <sub>A</sub> =25°C	ı	57	A	
Current	T <sub>A</sub> =70°C	DSM	45.5		
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	70	A	
Avalanche energy	L=0.3mH	E <sub>AS</sub>	735	mJ	
	T <sub>C</sub> =25°C	P <sub>D</sub>	272	W	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	r <sub>D</sub>	136	- vv	
	T <sub>A</sub> =25°C	P <sub>DSM</sub>	8.3	W	
Power Dissipation A	T <sub>A</sub> =70°C	FDSM	5.3	- vv	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	- R <sub>θJA</sub>	12	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	Г∖өЈА	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.42	0.55	°C/W	



## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		40			V
I <sub>DSS</sub> Z	Zero Gate Voltage Drain Current	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V				1	
			T <sub>J</sub> =55°C			5	μA
$I_{GSS}$	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=250\mu A$		1.3	1.8	2.3	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A			1.2	1.5	mΩ
			T <sub>J</sub> =125°C		1.75	2.2	
		$V_{GS}$ =4.5V, $I_{D}$ =20A			1.5	2.0	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			100		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.66	1	V
Is	Maximum Body-Diode Continuous Cur	Current <sup>G</sup>				195	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz			9985		pF
Coss	Output Capacitance				1635		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				95		pF
$R_g$	Gate resistance	f=1MHz		1.3	2.6	3.9	Ω
SWITCH	NG PARAMETERS	•	•		-	•	ē
Q <sub>g</sub> (10V)	Total Gate Charge				128	180	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge	\/ -10\/ \/ -20\/	1 -204		54	80	nC
$Q_{gs}$	Gate Source Charge	-V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A			29		nC
$Q_{gd}$	Gate Drain Charge				11		nC
Q <sub>oss</sub>	Output Charge	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V			67		nC
t <sub>D(on)</sub>	Turn-On DelayTime				16		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =1 $\Omega$ , $R_{GEN}$ =3 $\Omega$			16		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				125		ns
t <sub>f</sub>	Turn-Off Fall Time				27		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			29		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	l <sub>F</sub> =20A, di/dt=500A/μs			107		nC

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on  $R_{0JA}$  t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175 $^\circ$  C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =175 $^{\circ}$  C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

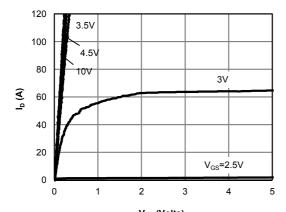
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J/MAX</sub>=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

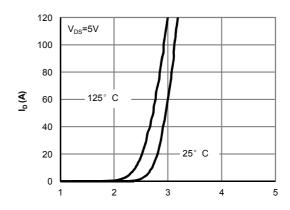
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



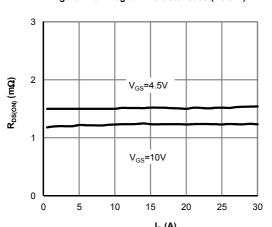
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



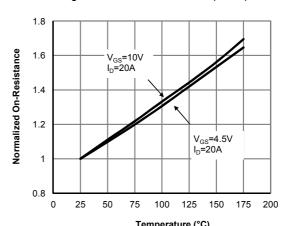
V<sub>DS</sub> (Volts) Figure 1: On-Region Characteristics (Note E)



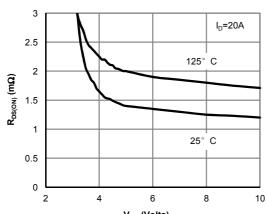
V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



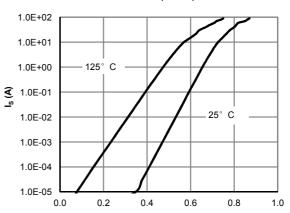
 $\label{eq:local_local} \textbf{I}_{\text{D}}\left(\textbf{A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



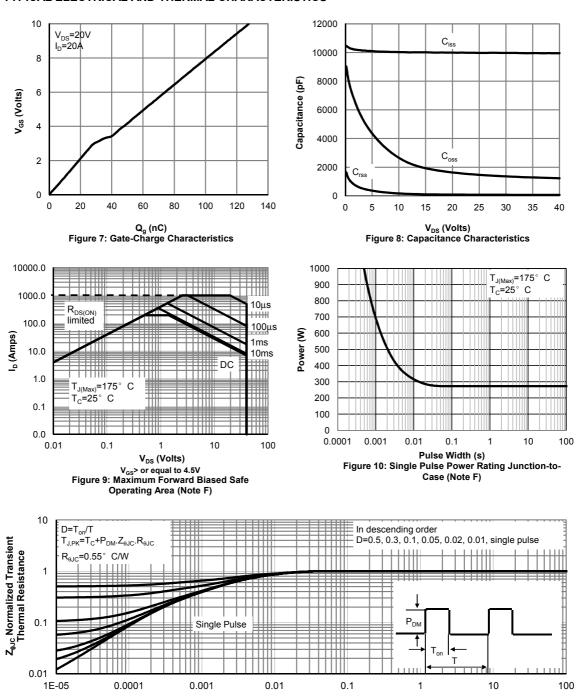
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



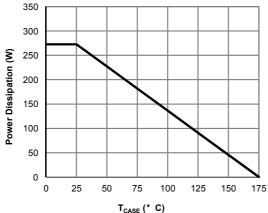
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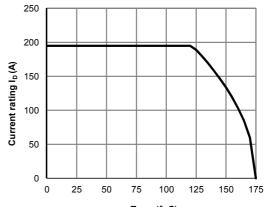


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

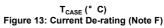


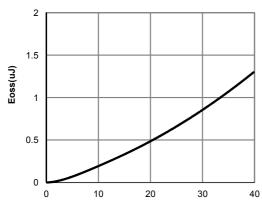
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



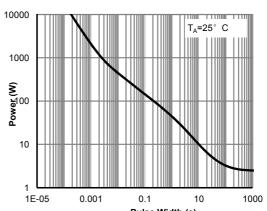


T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)

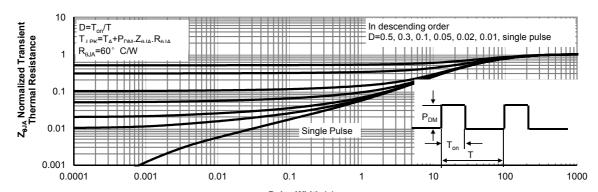




V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



Figure A: Gate Charge Test Circuit & Waveforms

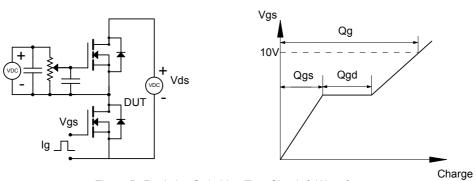


Figure B: Resistive Switching Test Circuit & Waveforms

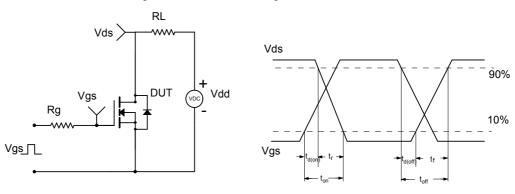


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

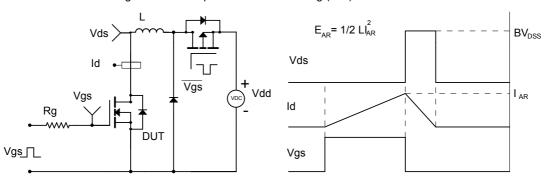


Figure D: Diode Recovery Test Circuit & Waveforms

